

<b>Notice of References Cited</b>	Application/Control No. 10/697,606		Applicant(s)/Patent Under Reexamination WOLFF, GREGORY	
	Examiner Hai V. Nguyen		Art Unit 2142	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,062,497	06-2006	Hamburg et al.	707/101
*	B	US-6,981,215	12-2005	Lindhorst et al.	715/530
*	C	US-6,882,995	04-2005	Nasr et al.	707/3
*	D	US-6,668,271	12-2003	Wolff, Gregory	709/202
*	E	US-6,658,624	12-2003	Savitzky et al.	715/513
*	F	US-6,571,271	05-2003	Savitzky et al.	709/200
*	G	US-6,562,076	05-2003	Edwards et al.	715/515
*	H	US-6,351,767	02-2002	Batchelder et al.	709/219
*	I	US-6,324,551	11-2001	Lamping et al.	715/500
*	J	US-6,240,405	05-2001	Suzuki, Hideo	706/45
*	K	US-6,170,007	01-2001	Venkatraman et al.	709/218
*	L	US-6,163,797	12-2000	Eckley et al.	709/203
*	M	US-6,012,083	01-2000	Savitzky et al.	709/202

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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